Notice of References Cited

Application/Control No. 10/817,553	Applicant(s)/Patent Under Reexamination REED, DAVID G.		
Examiner	Art Unit		
Christopher B. Shin	2181	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,862,673	03-2005	Lee et al.	711/169
*	В	US-6,832,279	12-2004	Potter et al.	710/112
*	С	US-6,721,813	04-2004	Owen et al.	710/6
*	D	US-6,243,781	06-2001	Gandhi et al.	710/313
*	Е	US-7,003,615	02-2006	Chui et al.	710/311
*	F	US-6,915,371	07-2005	Berndt et al.	710/310
*	G	US-2005/0223124	10-2005	Reed, David G.	710/005
*	Н	US-2003/0097514	05-2003	Ennis et al.	710/306
*	ı	US-2003/0093637	05-2003	Lee et al.	711/159
	J	US-			
	к	US-	, i		
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.